

<b>Notice of References Cited</b>	Application/Control No. 10/521,549	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Robert W. Horn	Art Unit 2837	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,347,459 A	09-1994	Greenspan et al.	700/255
*	B	US-RE36,631 E	03-2000	Tanabe et al.	318/568.13
*	C	US-6,597,971 B2	07-2003	Kanno, Ichiro	700/245
*	D	US-6,665,588 B2	12-2003	Watanabe et al.	700/259
*	E	US-6,907,309 B2	06-2005	Zipperer, Martin	700/130
*	F	US-6,917,855 B2	07-2005	Gonzalez-Banos et al.	700/245
*	G	US-6,933,695 B2	08-2005	Blumenkranz, Stephen J.	318/568.11
*	H	US-2006/0108960 A1	05-2006	Tanaka et al.	318/568.21
*	I	US-7,038,165 B2	05-2006	Okuda et al.	219/121.78
*	J	US-7,066,291 B2	06-2006	Martins et al.	180/167
*	K	US-7,079,924 B2	07-2006	Galbraith, John	700/245
*	L	US-7,103,145 B2	09-2006	Wong et al.	378/117
*	M	US-7,118,365 B2	10-2006	Shirahata et al.	425/139

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/521,549	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Robert W. Horn	Art Unit 2837	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,920,972 A	11-1975	Corwin et al.	700/251
*	B	US-RE30,132 E	10-1979	Irie, Akiyoshi	318/568.15
*	C	US-4,648,783 A	03-1987	Tan et al.	414/730
*	D	US-4,795,998 A	01-1989	Dunbar et al.	338/5
*	E	US-RE36,929 E	10-2000	Takayama et al.	318/568.11
*	F	US-6,668,951 B2	12-2003	Won, Chikyung	180/9.1
*	G	US-6,845,297 B2	01-2005	Allard, James R.	700/259
*	H	US-6,898,528 B2	05-2005	Zorka et al.	701/301
*	I	US-7,047,107 B2	05-2006	Minoshima et al.	700/245
*	J	US-7,127,100 B2	10-2006	Wenzel et al.	382/154
*	K	US-7,129,664 B2	10-2006	Kubo et al.	318/567
*	L	US-7,124,027 B1	10-2006	Ernst et al.	701/301
*	M	US-7,151,848 B1	12-2006	Watanabe et al.	382/141

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/521,549	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Robert W. Horn	Art Unit 2837	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,587,752 B1	07-2003	Saito, Fuminori	700/264
*	B	US-7,084,900 B1	08-2006	Watanabe et al.	348/94
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.